# STD3N80K5, STF3N80K5, STP3N80K5, STU3N80K5 

## N-channel 800 V, $2.8 \Omega$ typ., 2.5 A MDmesh ${ }^{\text {TM }}$ K5 Power MOSFETs in DPAK, TO-220FP, TO-220 and IPAK

Datasheet - production data


Figure 1: Internal schematic diagram


Features

| Order code | V ${ }_{\text {ds }}$ | RDS(on) max. | ID | Рtot |
| :---: | :---: | :---: | :---: | :---: |
| STD3N80K5 | 800 V | $3.5 \Omega$ | 2.5 A | 60 W |
| STF3N80K5 |  |  |  | 20 W |
| STP3N80K5 |  |  |  |  |
| STU3N80K5 |  |  |  | W |

- Industry's lowest $\mathrm{R}_{\mathrm{DS}(\text { on })} \mathrm{x}$ area
- Industry's best FoM (figure of merit)
- Ultra-low gate charge
- $100 \%$ avalanche tested
- Zener-protected


## Applications

- Switching applications


## Description

These very high voltage N -channel Power MOSFETs are designed using MDmesh ${ }^{\text {TM }}$ K5 technology based on an innovative proprietary vertical structure. The result is a dramatic reduction in on-resistance and ultra-low gate charge for applications requiring superior power density and high efficiency.

Table 1: Device summary

| Order code | Marking | Package | Packing |
| :---: | :---: | :---: | :---: |
| STD3N80K5 |  | DPAK | Tape and reel |
| STF3N80K5 | 3N80K5 | TO-220FP | Tube |
|  |  | TO-220 |  |
| STP3N80K5 |  | IPAK |  |
| STU3N80K5 |  |  |  |

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## 1 Electrical ratings

Table 2: Absolute maximum ratings

| Symbol | Parameter | Value |  |  |  | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  | DPAK | TO-220FP | TO-220 | IPAK |  |
| $V_{G S}$ | Gate-source voltage | $\pm 30$ |  |  |  | V |
| ID | Drain current (continuous) at $\mathrm{TC}=25^{\circ} \mathrm{C}$ | 2.5 |  |  |  | A |
| ID | Drain current (continuous) at $\mathrm{T}_{\mathrm{C}}=100^{\circ} \mathrm{C}$ | 1.6 |  |  |  | A |
| $\mathrm{ID}^{(1)}$ | Drain current (pulsed) | 10 |  |  |  | A |
| $\mathrm{P}_{\text {tot }}$ | Total dissipation at $\mathrm{T}_{\mathrm{C}}=25^{\circ} \mathrm{C}$ | 60 | 20 | 60 | 60 | W |
| Viso | Insulation withstand voltage (RMS) from all three leads to external heat-sink ( $\mathrm{t}=1 \mathrm{~s}, \mathrm{Tc}=25^{\circ} \mathrm{C}$ ) |  | 2.5 |  |  | kV |
| $\mathrm{dv} / \mathrm{dt}^{(2)}$ | Peak diode recovery voltage slope | 4.5 |  |  |  |  |
| $\mathrm{dv} / \mathrm{dt}^{(3)}$ | MOSFET dv/dt ruggedness | 50 |  |  |  | V/ns |
| $\mathrm{T}_{\mathrm{j}}$ | Operating junction temperature range | -55 to 150 |  |  |  | ${ }^{\circ} \mathrm{C}$ |
| $\mathrm{T}_{\text {stg }}$ | Storage temperature range |  |  |  |  |  |

## Notes:

${ }^{(1)}$ Pulse width limited by safe operating area.
${ }^{(2)}{ }_{I S D} \leq 2.5 \mathrm{~A}, \mathrm{di} / \mathrm{dt}=100 \mathrm{~A} / \mu \mathrm{s} ; \mathrm{V}_{\mathrm{DS}}$ peak $<\mathrm{V}_{(\mathrm{BR}) \mathrm{DSS}}$.
${ }^{(3)} \mathrm{V}_{\mathrm{DS}} \leq 640 \mathrm{~V}$.

Table 3: Thermal data

| Symbol | Parameter | Value |  |  |  | Unit |  |
| :---: | :--- | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  |  | DPAK | TO-220FP | TO-220 |  |  |
| $R_{\text {thj-case }}$ | Thermal resistance junction-case | 2.08 | 6.25 | 2.08 |  | ${ }^{\circ} \mathrm{C} / \mathrm{W}$ |  |
| $R_{\text {thi-amb }}$ | Thermal resistance junction-ambient |  | 62.5 | 62.5 | 100 | ${ }^{\circ} \mathrm{C} / \mathrm{W}$ |  |
| $R_{\text {thijpcb }}{ }^{(1)}$ | Thermal resistance junction-pcb | 50 |  |  |  | ${ }^{\circ} \mathrm{C} / \mathrm{W}$ |  |

## Notes:

${ }^{(1)}$ When mounted on FR-4 board of 1 inch $^{2}, 2 \mathrm{oz} \mathrm{Cu}$.

Table 4: Avalanche characteristics

| Symbol | Parameter | Value | Unit |
| :---: | :--- | :---: | :---: |
| $I_{A R}$ | Avalanche current, repetitive or not repetitive (pulse width limited by $\left.T_{j m a x}\right)$ | 1 | $A$ |
| $\mathrm{E}_{\mathrm{AS}}$ | Single pulse avalanche energy (starting $\mathrm{T}_{\mathrm{j}}=25^{\circ} \mathrm{C}, \mathrm{I}_{\mathrm{D}}=\mathrm{I}_{\mathrm{AR}}, \mathrm{V}_{\mathrm{DD}}=50 \mathrm{~V}$ ) | 65 | mJ |

## 2 Electrical characteristics

$\mathrm{T}_{\mathrm{C}}=25^{\circ} \mathrm{C}$ unless otherwise specified
Table 5: On/off-state

| Symbol | Parameter | Test conditions | Min. | Typ. | Max. | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| $V_{\text {(BR) }{ }^{\text {dSS }}}$ | Drain-source breakdown voltage | $\mathrm{V}_{\mathrm{GS}}=0 \mathrm{~V}, \mathrm{ID}=1 \mathrm{~mA}$ | 800 |  |  | V |
| Idss | Zero gate voltage drain current | $\mathrm{V}_{\mathrm{GS}}=0 \mathrm{~V}, \mathrm{~V}_{\mathrm{DS}}=800 \mathrm{~V}$ |  |  | 1 | $\mu \mathrm{A}$ |
|  |  | $\begin{aligned} & \mathrm{V}_{\mathrm{GS}}=0 \mathrm{~V}, \mathrm{~V}_{\mathrm{DS}}=800 \mathrm{~V}, \\ & \mathrm{~T}_{\mathrm{C}}=125^{\circ} \mathrm{C}^{(1)} \end{aligned}$ |  |  | 50 | $\mu \mathrm{A}$ |
| Igss | Gate body leakage current | $\mathrm{V} \mathrm{DS}=0 \mathrm{~V}, \mathrm{~V}_{\mathrm{GS}}= \pm 20 \mathrm{~V}$ |  |  | $\pm 10$ | $\mu \mathrm{A}$ |
| VGS(th) | Gate threshold voltage | $\mathrm{V}_{\mathrm{DD}}=\mathrm{V}_{\mathrm{GS}}, \mathrm{ld}=100 \mu \mathrm{~A}$ | 3 | 4 | 5 | V |
| RDS(on) | Static drain-source on-resistance | $\mathrm{VGS}=10 \mathrm{~V}, \mathrm{ld}=1 \mathrm{~A}$ |  | 2.8 | 3.5 | $\Omega$ |

## Notes:

${ }^{(1)}$ Defined by design, not subject to production test.

Table 6: Dynamic

| Symbol | Parameter | Test conditions | Min. | Typ. | Max. | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| Ciss | Input capacitance | $\begin{aligned} & \mathrm{VDS}=100 \mathrm{~V}, \mathrm{f}=1 \mathrm{MHz}, \\ & \mathrm{~V}_{\mathrm{GS}}=0 \mathrm{~V} \end{aligned}$ | - | 130 | - | pF |
| Coss | Output capacitance |  | - | 14 | - | pF |
| Crss | Reverse transfer capacitance |  | - | 0.6 | - | pF |
| $\mathrm{C}_{0(t r)^{(1)}}$ | Equivalent capacitance time related | V GS $=0 \mathrm{~V}, \mathrm{~V}$ DS $=0$ to 640 V | - | 20 | - | pF |
| $\mathrm{Co}_{\text {(er) }}{ }^{(2)}$ | Equivalent capacitance energy related |  | - | 9 | - | pF |
| $\mathrm{R}_{\mathrm{g}}$ | Intrinsic gate resistance | $\mathrm{f}=1 \mathrm{MHz}, \mathrm{ld}=0 \mathrm{~A}$ | - | 15.5 | - | $\Omega$ |
| $\mathrm{Q}_{\mathrm{g}}$ | Total gate charge | $\begin{aligned} & \mathrm{V}_{\mathrm{DD}}=640 \mathrm{~V}, \mathrm{I}_{\mathrm{D}}=2.5 \mathrm{~A} \\ & \mathrm{~V}_{\mathrm{GS}}=0 \text { to } 10 \mathrm{~V} \end{aligned}$ <br> (see Figure 19: "Test circuit for gate charge behavior") | - | 9.5 | - | nC |
| $\mathrm{Q}_{\mathrm{gs}}$ | Gate-source charge |  | - | 1.5 | - | nC |
| $\mathrm{Q}_{\mathrm{gd}}$ | Gate-drain charge |  | - | 7.5 | - | nC |

## Notes:

${ }^{(1)} \mathrm{C}_{o(t r)}$ is a constant capacitance value that gives the same charging time as $\mathrm{C}_{\text {oss }}$ while $\mathrm{V}_{\mathrm{DS}}$ is rising from 0 to $80 \%$ VDss.
${ }^{(2)} \mathrm{C}_{0 \text { (er) }}$ is a constant capacitance value that gives the same stored energy as Coss while $V_{D S}$ is rising from 0 to 80\% VDss.

Table 7: Switching times

| Symbol | Parameter | Test conditions | Min. | Typ. | Max. | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| $\mathrm{t}_{\text {d}(0 n) ~}^{\text {a }}$ | Turn-on delay time | $\begin{aligned} & \mathrm{V}_{\mathrm{DD}}=400 \mathrm{~V}, \mathrm{ID}_{\mathrm{D}}=1.25 \mathrm{~A}, \mathrm{R}_{\mathrm{G}}=4.7 \Omega \\ & \mathrm{~V}_{\mathrm{GS}}=10 \mathrm{~V} \end{aligned}$ <br> (see Figure 18: "Test circuit for resistive load switching times" and Figure 23: "Switching time waveform") | - | 8.5 | - | ns |
| tr | Rise time |  | - | 10.5 | - | ns |
| $\mathrm{t}_{\text {d(off) }}$ | Turn-off delay time |  | - | 20.5 | - | ns |
| $\mathrm{tf}^{\text {f }}$ | Fall time |  | - | 25 | - | ns |

Table 8: Source-drain diode

| Symbol | Parameter | Test conditions | Min. | Typ. | Max. | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| Isd | Source-drain current |  | - |  | 2.5 | A |
| Isbm ${ }^{(1)}$ | Source-drain current (pulsed) |  | - |  | 10 | A |
| $\mathrm{VSD}^{(2)}$ | Forward on voltage | $\mathrm{ISD}=2.5 \mathrm{~A}, \mathrm{~V}_{\mathrm{GS}}=0 \mathrm{~V}$ | - |  | 1.5 | V |
| trr | Reverse recovery time | $\mathrm{ISD}=2.5 \mathrm{~A}, \mathrm{di} / \mathrm{dt}=100 \mathrm{~A} / \mu \mathrm{s}$, <br> $V_{D D}=60 \mathrm{~V}$ (see Figure 20: "Test circuit for inductive load switching and diode recovery times') | - | 265 |  | ns |
| Qrr | Reverse recovery charge |  | - | 1.2 |  | $\mu \mathrm{C}$ |
| IRRM | Reverse recovery current |  | - | 9.2 |  | A |
| $t_{\text {rr }}$ | Reverse recovery time | $\mathrm{I}_{\mathrm{sD}}=2.5 \mathrm{~A}, \mathrm{di} / \mathrm{dt}=100 \mathrm{~A} / \mu \mathrm{s}$, $\mathrm{V}_{\mathrm{DD}}=60 \mathrm{~V}, \mathrm{~T}_{\mathrm{j}}=150^{\circ} \mathrm{C}$ ( see Figure 20: "Test circuit for inductive load switching and diode recovery times") | - | 430 |  | ns |
| Qrr | Reverse recovery charge |  | - | 1.9 |  | $\mu \mathrm{C}$ |
| IRRM | Reverse recovery current |  | - | 8.8 |  | A |

## Notes:

${ }^{(1)}$ Pulse width limited by safe operating area
${ }^{(2)}$ Pulsed: pulse duration $=300 \mu \mathrm{~s}$, duty cycle $1.5 \%$

Table 9: Gate-source Zener diode

| Symbol | Parameter | Test conditions | Min. | Typ. | Max. | Unit |
| :---: | :--- | :--- | :---: | :---: | :---: | :---: |
| $\mathrm{V}_{(\mathrm{BR}) \mathrm{GsO}}$ | Gate-source <br> breakdown voltage | $\mathrm{I}_{\mathrm{GS}}= \pm 1 \mathrm{~mA}, \mathrm{I}_{\mathrm{D}}=0 \mathrm{~A}$ | $\pm 30$ | - | - | V |

The built-in back-to-back Zener diodes are specifically designed to enhance the ESD performance of the device. The Zener voltage facilitates efficient and cost-effective device integrity protection, thus eliminating the need for additional external componentry.

### 2.1 Electrical characteristics (curves)

Figure 2: Safe operating area for DPAK and IPAK


Figure 3: Thermal impedance for DPAK and IPAK


Figure 4: Safe operating area for TO-220FP


Figure 5: Thermal impedance for TO-220FP


Figure 6: Safe operating area for TO-220


Figure 7: Thermal impedance for TO-220



Figure 10: Gate charge vs gate-source voltage


Figure 11: Static drain-source on-resistance


Figure 13: Output capacitance stored energy



Figure 15: Normalized on-resistance vs temperature


Figure 16: Normalized VDS vs temperature


Figure 17: Source-drain diode forward characteristics


## 3 Test circuits



## 4 Package information

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK ${ }^{\circledR}$ packages, depending on their level of environmental compliance. ECOPACK ${ }^{\circledR}$ specifications, grade definitions and product status are available at: www.st.com. ECOPACK ${ }^{\circledR}$ is an ST trademark.

### 4.1 DPAK (TO-252) type A package information

Figure 24: DPAK (TO-252) type A package outline


Table 10: DPAK (TO-252) type A mechanical data

| Dim. | mm |  |  |
| :---: | :---: | :---: | :---: |
|  | Min. | Typ. | Max. |
| A | 2.20 |  | 2.40 |
| A1 | 0.90 |  | 1.10 |
| A2 | 0.03 |  | 0.23 |
| b | 0.64 |  | 0.90 |
| b4 | 5.20 |  | 5.40 |
| c | 0.45 |  | 0.60 |
| c2 | 0.48 |  | 0.60 |
| D | 6.00 |  | 6.20 |
| D1 | 4.95 | 5.10 | 5.25 |
| E | 6.40 |  | 6.60 |
| E1 | 4.60 | 4.70 | 4.80 |
| e | 2.16 | 2.28 | 2.40 |
| e1 | 4.40 |  | 4.60 |
| H | 9.35 |  | 10.10 |
| L | 1.00 |  | 1.50 |
| (L1) | 2.60 | 2.80 | 3.00 |
| L2 | 0.65 | 0.80 | 0.95 |
| L4 | 0.60 |  | 1.00 |
| R |  | 0.20 |  |
| V2 | $0^{\circ}$ |  | $8^{\circ}$ |

Figure 25: DPAK (TO-252) type A recommended footprint (dimensions are in mm)


### 4.2 DPAK (TO-252) type E package information

Figure 26: DPAK (TO-252) type E package outline


Table 11: DPAK (TO-252) type E mechanical data

| Dim. | mm |  |  |
| :---: | :---: | :---: | :---: |
|  | Min. | Typ. | Max. |
| A | 2.18 |  | 2.39 |
| A2 |  |  | 0.13 |
| b | 0.65 |  | 0.884 |
| b4 | 4.95 |  | 5.46 |
| c | 0.46 |  | 0.61 |
| c2 | 0.46 |  | 0.60 |
| D | 5.97 |  | 6.22 |
| D1 | 5.21 |  |  |
| E | 6.35 |  | 6.73 |
| E1 | 4.32 |  |  |
| e |  |  | 10.34 |
| e1 | 9.94 |  | 1.78 |
| H | 1.50 |  | 1.272 |
| L |  |  | 1.02 |
| L1 | 0.89 |  |  |
| L2 |  |  |  |
| L4 |  |  |  |

Figure 27: DPAK (TO-252) type E recommended footprint (dimensions are in mm)


### 4.3 DPAK (TO-252) packing information

Figure 28: DPAK (TO-252) tape outline


Figure 29: DPAK (TO-252) reel outline


Table 12: DPAK (TO-252) tape and reel mechanical data

| Tape |  |  | Reel |  |  |
| :---: | :---: | :---: | :---: | :---: | :---: |
| Dim. | $\mathbf{m m}$ |  | Dim. | $\mathbf{m m}$ |  |
|  | Min. | Max. |  | Min. | Max. |
| A0 | 6.8 | 7 | A |  | 330 |
| B0 | 10.4 | 10.6 | B | 1.5 |  |
| B1 |  | 12.1 | C | 12.8 | 13.2 |
| D | 1.5 | 1.6 | D | 20.2 |  |
| D1 | 1.5 |  | G | 16.4 | 18.4 |
| E | 1.65 | 1.85 | N | 50 |  |
| F | 7.4 | 7.6 | T |  | 22.4 |
| K0 | 2.55 | 2.75 |  |  |  |
| P0 | 3.9 | 4.1 |  | Base qty. | 2500 |
| P1 | 7.9 | 8.1 |  | Bulk qty. | 2500 |
| P2 | 1.9 | 2.1 |  |  |  |
| R | 40 |  |  |  |  |
| T | 0.25 | 0.35 |  |  |  |
| W | 15.7 | 16.3 |  |  |  |

### 4.4 TO-220FP package information

Figure 30: TO-220FP package outline


Table 13: TO-220FP package mechanical data

| Dim. | mm |  |  |
| :---: | :---: | :---: | :---: |
|  | Min. | Typ. | Max. |
| A | 4.4 |  | 4.6 |
| B | 2.5 |  | 2.7 |
| D | 2.5 |  | 2.75 |
| E | 0.45 |  | 0.7 |
| F | 0.75 |  | 1 |
| F1 | 1.15 |  | 1.70 |
| F2 | 1.15 |  | 1.70 |
| G | 4.95 |  | 5.2 |
| G1 | 2.4 |  | 2.7 |
| H | 10 |  | 10.4 |
| L2 | 28.6 |  | 30.6 |
| L3 | 9.8 |  | 10.6 |
| L4 | 2.9 |  | 3.6 |
| L5 | 15.9 |  | 16.4 |
| L6 | 9 |  | 9.3 |
| L7 | 3 |  | 3.2 |
| Dia |  |  |  |

### 4.5 TO-220 type A package information

Figure 31: TO-220 type A package outline


Table 14: TO-220 type A package mechanical data

| Dim. | mm |  |  |
| :---: | :---: | :---: | :---: |
|  | Min. | Typ. | Max. |
| A | 4.40 |  | 4.60 |
| b | 0.61 |  | 0.88 |
| b1 | 1.14 |  | 1.55 |
| c | 0.48 |  | 0.70 |
| D | 15.25 |  | 15.75 |
| D1 |  |  | 1.27 |
| E | 10.00 |  | 10.40 |
| e | 2.40 |  | 2.70 |
| e1 | 4.95 |  | 1.32 |
| F | 1.23 |  | 6.60 |
| H1 | 6.20 |  | 2.72 |
| J1 | 2.40 |  | 14.00 |
| L | 13.00 |  | 3.93 |
| L1 | 3.50 |  | 3.40 |
| L20 |  |  | 2.90 |
| L30 |  |  |  |
| ¢P | 3.75 |  |  |
| Q | 2.65 |  |  |

### 4.6 IPAK (TO-251) type A package information

Figure 32: IPAK (TO-251) type A package outline


Table 15: IPAK (TO-251) type A package mechanical data

| Dim. | mm |  |  |
| :---: | :---: | :---: | :---: |
|  | Min. | Typ. | Max. |
| A | 2.20 |  | 2.40 |
| A1 | 0.90 |  | 1.10 |
| b | 0.64 |  | 0.90 |
| b2 |  |  | 0.95 |
| b4 | 5.20 |  | 5.40 |
| B5 | 0.45 |  |  |
| c | 0.48 |  | 0.30 |
| c2 | 6.00 |  | 0.60 |
| D | 6.40 |  | 6.20 |
| E | 4.40 |  | 6.60 |
| e |  |  | 46.10 |
| e1 | 9.00 |  | 9.60 |
| H | 0.80 |  | 1.20 |
| L |  |  | 1.00 |
| L1 |  |  |  |
| L2 |  |  |  |
| V1 |  |  |  |

## 5 Revision history

Table 16: Document revision history

| Date | Revision | Changes |
| :---: | :---: | :--- |
| 12-Jul-2013 | 1 | First release. |
| 15-Jan-2014 | 2 | - Modified: PTOT and EAS values in Table 2 <br> - Modified: Rthj-case values in Table 3 <br> - Modified: the entire typical values in Table 5 and 6 <br> - Modified: ISD and ISDM max values and typical values in Table 7 <br> - Updated: Table 24 and Table 9 <br> - Added: Section 2.1: Electrical characteristics (curves) <br> - Minor text changes |
| 17-Jan-2014 | 3 | - Modified: Figure 8 and 9 <br> - Minor text changes |
| 17-Jul-2017 | 4 | Updated Table 7: "Switching times" and Section 4: "Package information". <br> Minor text changes. |

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